

SBAS396-JUNE 2007

16-Bit, Single-Channel, ±18V Output (Unbuffered), Ultra-Low Power, Serial Interface DIGITAL-TO-ANALOG CONVERTER

FEATURES

• 16-Bit Resolution

Output: ±18V for ±18V Reference Input

• ±18V Supply Operation

Very Low Power

High Accuracy INL: 1LSB
 Low Noise: 10nV/√Hz

Fast Settling: 1μs to 1LSB

• Fast SPI™ Interface: Up To 50MHz

• 16-Pin TSSOP Package

Selectable Reset to Zero or Midscale

APPLICATIONS

• Portable Equipment

• Automatic Test Equipment

Industrial Process Control

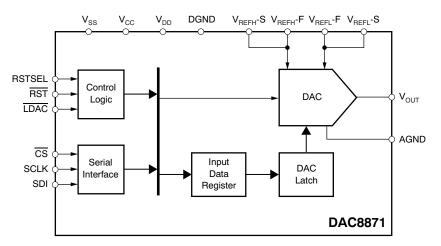
• Data Acquisition Systems

Optical Networking

DESCRIPTION

The DAC8871 is a 16-bit, single-channel, serial input, voltage output digital-to-analog converter (DAC). The output range is determined by the reference voltage, V_{REFH} and $V_{\text{REFL}}.$ By properly selecting the reference, the output can be unipolar or bipolar, and up to $\pm 18 \, \text{V}.$ These converters provide excellent linearity (1LSB INL), low noise, and fast settling (1µs to 1LSB of full scale output) over the specified temperature range of $-40\,^{\circ}\text{C}$ to $+105\,^{\circ}\text{C}.$ The output is unbuffered, which reduces the power consumption and the error introduced by the buffer. The device features a standard high-speed clock (up to 50MHz), and a 3V or 5V SPI serial interface to communicate with the DSP or microprocessors.

For optimum performance, a set of Kelvin connections to external reference are provided. The DAC8871 is available in a TSSOP-16 package.





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This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

ORDERING INFORMATION(1)

PRODUCT	MINIMUM RELATIVE DIFFERENTIAL ACCURACY NONLINEARITY PRODUCT (LSB) (LSB)		SPECIFIED TEMPERATURE RANGE	PACKAGE MARKING	PACKAGE- LEAD	PACKAGE DESIGNATOR
DAC8871B	±1	±1	-40°C to +105°C	8871	TSSOP-16	PW
DAC8871	±3	±1	-40°C to +105°C	8871	TSSOP-16	PW

⁽¹⁾ For the most current package and ordering information, see the Package Option Addendum at the end of this data sheet, or see the TI website at www.ti.com.

ABSOLUTE MAXIMUM RATINGS(1)

over operating free-air temperature range (unless otherwise noted).

	DAC8871	UNIT
V _{DD} to GND	-0.3 to +7	V
Digital input voltage to GND	-0.3 to (V _{DD} + 0.3)	V
AGND to DGND	-0.3 to +0.3	V
V _{CC} to V _{SS}	-0.3 to +39.6	V
V _{CC} to AGND	-0.3 to +19.8	V
V _{SS} to AGND	+0.3 to -19.8	V
V _{REFH} to VREFL	-0.3 to +39.6	V
V _{REFH} to AGND	-0.3 to +19.8	V
V _{REFL} to AGND	-19.8 to +17.5	V
Operating temperature range	-40 to +105	°C
Storage temperature range	-65 to +150	°C
Maximum junction temperature (T _J max)	+150	°C
Power dissipation	$(T_J max - T_A)/\theta_{JA}$	W
Thermal impedance, θ _{JA} TSSOP-16	161.4	°C/W

⁽¹⁾ Stresses above those listed under absolute maximum ratings may cause permanent damage to the device. Exposure to absolute maximum conditions for extended periods may affect device reliability.



ELECTRICAL CHARACTERISTICS

All specifications at $T_A = T_{MIN}$ to T_{MAX} , $V_{CC} = +15V$, $V_{SS} = -15V$, $V_{REFH} = +10V$, $V_{REFL} = -10V$, and $V_{DD} = +5V$, unless otherwise noted; specifications subject to change without notice.

					DAC8871			
PARAMETER		AMETER	CONDITIONS	MIN	MIN TYP MAX			
STATI	C PERFORMANCE					'		
	Resolution			16			Bits	
		DA 00074D	V _{REFH} = 10V, V _{REFL} = -5V		±0.75	±1	LSB	
	Linearity error	DAC8871B	$V_{REFH} = 10V$, $V_{REFL} = -10V$		±1	±1.5	LSB	
		DAC8871			±1	±3	LSB	
	Differential linearit	y error			±0.25	±1	LSB	
	Gain error		T _A = +25°C		±0.5	±2	LSB	
	Gain drift				±0.1		ppm/°C	
	Bipolar zero error		T _A = +25°C		±1	±4	LSB	
	Bipolar drift				±0.1		ppm/°C	
	Zero code error		T _A = +25°C		±0.5	±2	LSB	
	Zero code drift				±0.05		ppm/°C	
OUTP	JT CHARACTERIS	TICS				'		
	Voltage output			V_{REFL}		V_{REFH}	V	
	Output impedance)			6.25		kΩ	
	Settling time		To 1LSB of FS, C _L = 15 pF		1		μs	
	Slew rate ⁽¹⁾		C _L = 15pF		40		V/µs	
	Digital feedthroug	h ⁽²⁾			0.2		nV-s	
	Output noise		T _A = +25°C		10		nV/√ Hz	
Power supply rejection		ction	Supplies vary ±10%			±1	LSB	
REFE	RENCE INPUT					'		
V_{REFH}	Ref high input volt	age range		0		+18	V	
V _{REFL}	Ref low input volta	age range		-18	V _F	_{REFH} – 1.25	V	
	Ref high input cur	rent			1.3		mA	
	Ref low input curr	ent			-1.3		mA	
	Reference input in	npedance ⁽³⁾		7.5			kΩ	
	5.4		Code = 0000h		75		pF	
	Reference input c	apacitance	Code = FFFFh		120		pF	
DIGITA	AL INPUTS			1				
,	1		V _{DD} = +5V	DGND		0.8	V	
V _{IL}	Input low voltage		$V_{DD} = +3V$	DGND		0.6	V	
.,	1		V _{DD} = +5V	2.6		V_{DD}	V	
V _{IH}	Input high voltage		$V_{DD} = +3V$	2.1		V _{DD}	V	
	Input current					±1	μΑ	
	Input capacitance					10	pF	

Slew Rate is measure from 10% to 90% of transition when the output changes from 0 to full scale.

Digital feedthrough is defined as the impulse injected into the analog output from the digital input. It is measured when the DAC output does not change; CS is held high, while SCLK and DIN signals are toggled. It is specified with a full-scale code change on the SDI bus (that is, from all 0s to all 1s and vise versa).

Reference input resistance is code-dependent, with a minimum at 8555h



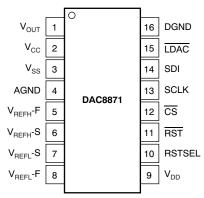
All specifications at $T_A = T_{MIN}$ to T_{MAX} , $V_{CC} = +15V$, $V_{SS} = -15V$, $V_{REFH} = +10V$, $V_{REFL} = -10V$, and $V_{DD} = +5V$, unless otherwise noted; specifications subject to change without notice.

		DAC8871		 	
PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT
POWER SUPPLY					
V _{CC}		+13.5	+15	+19.8	V
V _{SS}		-19.8	-15	-13.5	V
V_{DD}		+2.7		+5.5	V
Icc			0.01	2	μΑ
I _{SS}			-0.01	-2	μΑ
I _{DD}			3	10	μΑ
Power			15	30	μW
TEMPERATURE RANGE					
Specified performance		-40		+105	°C



PIN CONFIGURATION (NOT TO SCALE)





TERMINAL FUNCTIONS

TERI	MINAL	DESCRIPTION				
NO.	NAME	DESCRIPTION				
1	V _{OUT}	Analog output of the DAC				
2	V _{CC}	Positive analog power supply: +15V				
3	V_{SS}	Negative analog power supply: –15V				
4	AGND	Analog ground				
5	$V_{REFH}F$	V _{REFH} reference input (Force). Connect to external V _{REFH} .				
6	V _{REFH-} S	V _{REFH} reference input (Sense). Connect to external V _{REFH} .				
7	V _{REFL} -S	V _{REFL} reference input (Sense). Connect to external V _{REFL} .				
8	V_{REFL} F	V _{REFL} reference input (Force). Connect to external V _{REFL} .				
9	V_{DD}	Digital power. +5V for 5V interface logic; +3V for 3V logic.				
10	RSTSEL	Power-On-Reset select. Determines V_{OUT} after power-on reset. If tied to V_{DD} , the DAC latch is set to mid-scale after power-on, and V_{OUT} is $(V_{REFH}-V_{REFL})/2$. If tied to DGND, the DAC latch is cleared ('0'), and V_{OUT} is V_{REFL} .				
11	RST	Reset (active low)				
12	CS	Chip select input (active low). Data are not clocked into SDI unless CS is low.				
13	SCLK	Serial clock input				
14	SDI	Serial data input. Data are latched into input register on the rising edge of SCLK.				
15	LDAC	Load DAC control input (active low). When $\overline{\text{LDAC}}$ is low, the DAC latch is simultaneously updated with the content of the input register.				
16	DGND	Digital ground				



TIMING DIAGRAMS

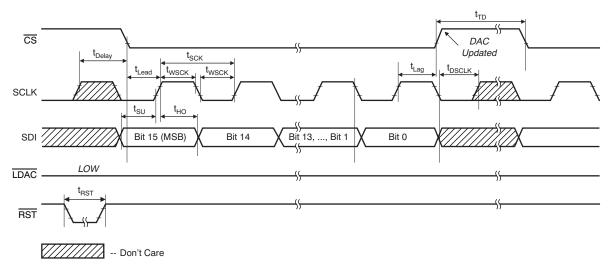


Figure 1. Case 1—LDAC Tied Low

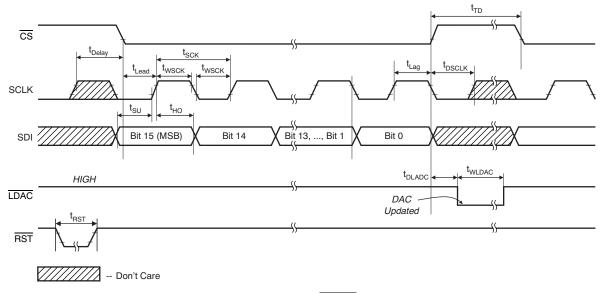


Figure 2. Case 2—LDAC Active



TIMING CHARACTERISTICS: $V_{DD} = +5V^{(1)(2)}$

At -40° C to $+105^{\circ}$ C, unless otherwise noted.

	PARAMETER	MIN	MAX	UNIT
t _{SCK}	SCLK period	20		ns
t _{WSCK}	SCLK high or low time	10		ns
t _{Delay}	Delay from SCLK high to CS low	10		ns
t _{Lead}	CS enable lead time	10		ns
t _{Lag}	CS enable lag time	10		ns
t _{DSCLK}	Delay from CS high to SCLK high	10		ns
t _{TD}	CS high between active period	30		ns
t _{SU}	Data setup time (input)	10		ns
t _{HO}	Data hold time (input)	0		ns
t _{WLDAC}	LDAC width	30		ns
t _{DLDAC}	Delay from CS high to LDAC low	30		ns
t _{RST}	Reset (RST) low	10		ns
	V _{DD} high to $\overline{\text{CS}}$ low (power-up delay)	10		μs

⁽¹⁾ Assured by design. Not production tested.(2) Sample tested during the initial release and after any redesign or process changes that may affect this parameter.



TYPICAL CHARACTERISTICS

At T_A = +25°C, V_{DD} = +5V, V_{CC} = +15V, V_{SS} = -15V, V_{REFH} = +10V, and V_{REFL} =-10V, unless otherwise noted.

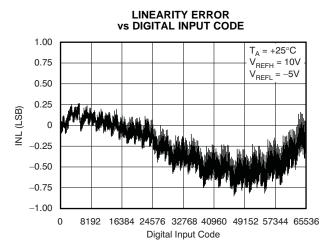


Figure 3.

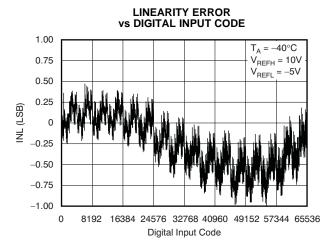


Figure 5.

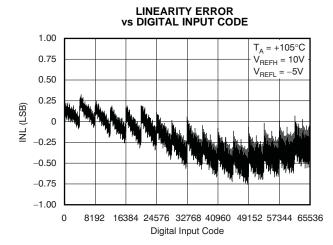


Figure 7.

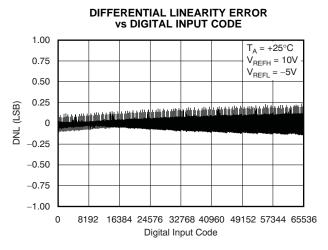
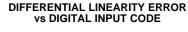


Figure 4.



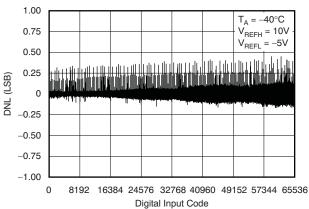


Figure 6.

DIFFERENTIAL LINEARY ERROR vs DIGITAL INPUT CODE

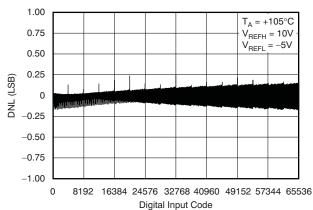


Figure 8.



At $T_A = +25$ °C, $V_{DD} = +5$ V, $V_{CC} = +15$ V, $V_{SS} = -15$ V, $V_{REFH} = +10$ V, and $V_{REFL} = -10$ V, unless otherwise noted.

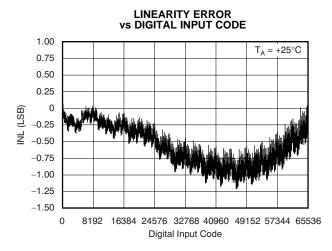


Figure 9.

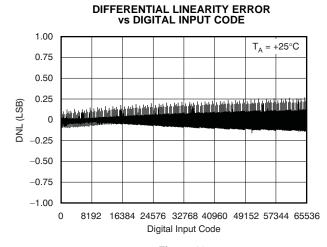


Figure 10.

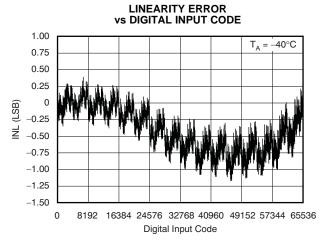


Figure 11.

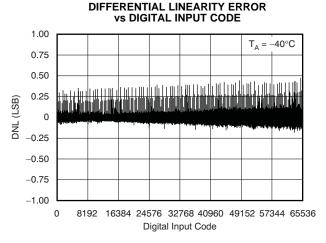


Figure 12.

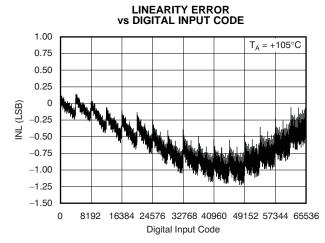


Figure 13.

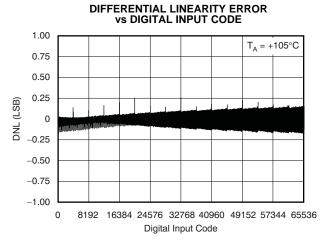


Figure 14.



At T_A = +25°C, V_{DD} = +5V, V_{CC} = +15V, V_{SS} = -15V, V_{REFH} = +10V, and V_{REFL} =-10V, unless otherwise noted.

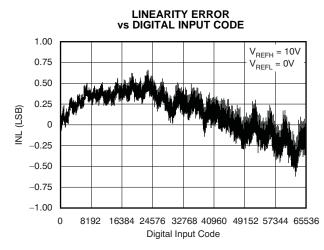


Figure 15.

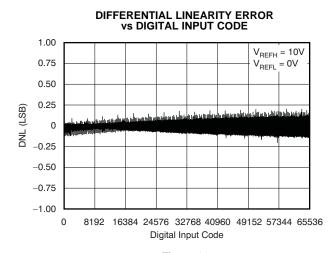


Figure 16.

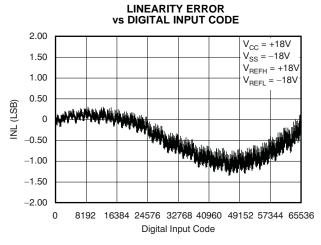


Figure 17.

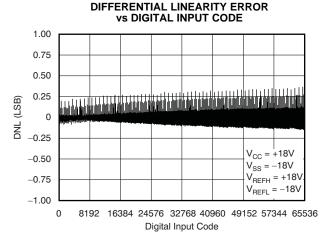


Figure 18.

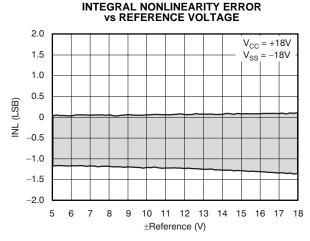


Figure 19.

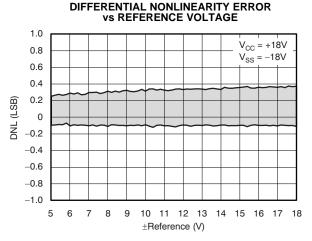


Figure 20.



At $T_A = +25$ °C, $V_{DD} = +5V$, $V_{CC} = +15V$, $V_{SS} = -15V$, $V_{REFH} = +10V$, and $V_{REFL} = -10V$, unless otherwise noted.

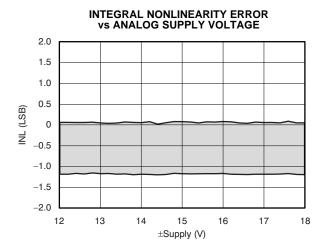


Figure 21.

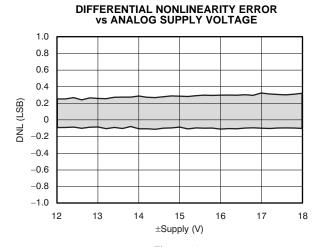


Figure 22.

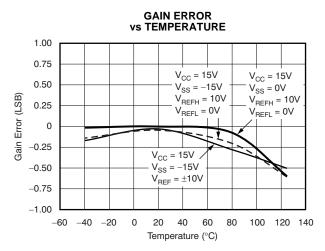


Figure 23.

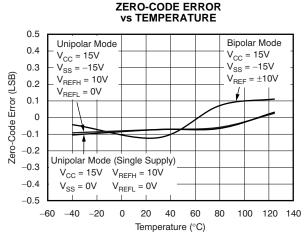


Figure 24.

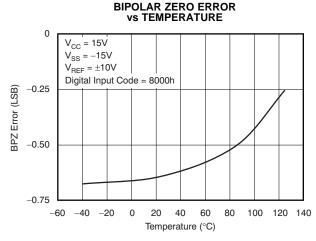


Figure 25.

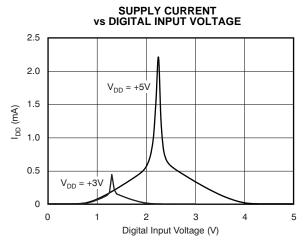


Figure 26.



At $T_A = +25$ °C, $V_{DD} = +5$ V, $V_{CC} = +15$ V, $V_{SS} = -15$ V, $V_{REFH} = +10$ V, and $V_{REFL} = -10$ V, unless otherwise noted.

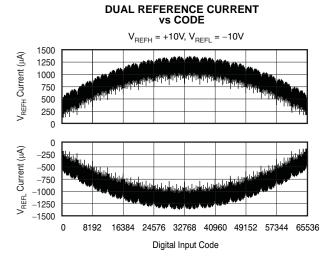


Figure 27.

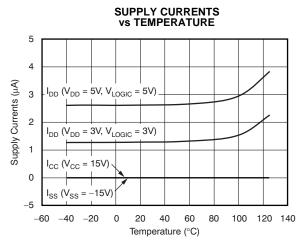


Figure 29.

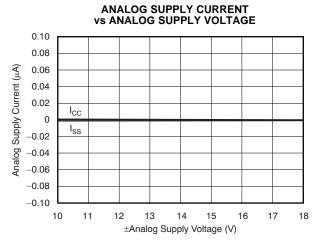


Figure 31.

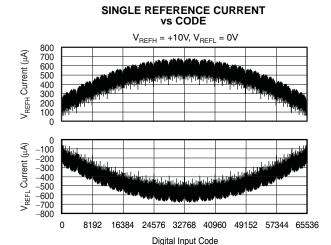


Figure 28.

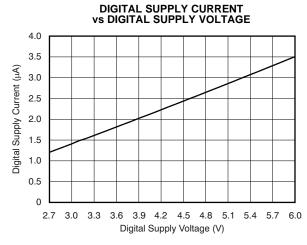


Figure 30.

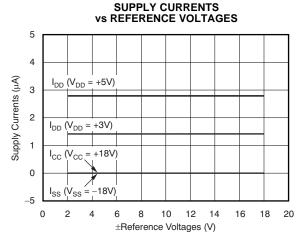
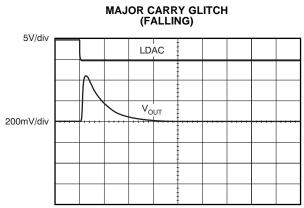


Figure 32.

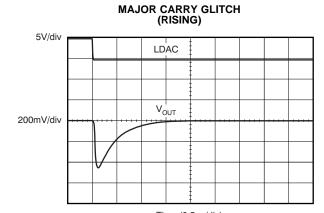


At T_A = +25°C, V_{DD} = +5V, V_{CC} = +15V, V_{SS} = -15V, V_{REFH} = +10V, and V_{REFL} =-10V, unless otherwise noted.



Time $(0.5\mu\text{s/div})$

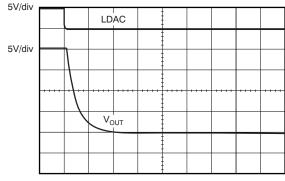
Figure 33.



Time (0.5 μ s/div)

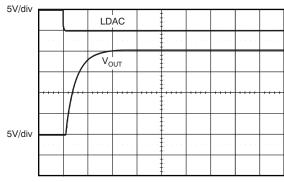
Figure 34.





Time (0.5µs/div)

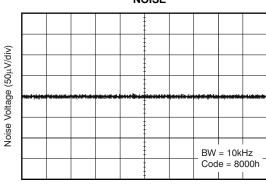
DAC SETTLING TIME (RISING)



Time $(0.5\mu s/div)$

Figure 35. Figure 36.

BROADBAND NOISE



Time (10µs/div)

Figure 37.



THEORY OF OPERATION

GENERAL DESCRIPTION

The DAC8871 is a 16-bit, single-channel, serial-input, voltage-output DAC. It operates from a dual power supply ranging from $\pm 13.5 \text{V}$ to $\pm 19.8 \text{V}$, and typically consumes $10 \mu \text{A}$. The output range is from V_{REFL} to V_{REFH} . Data are written to this device in a 16-bit word format, via an SPI serial interface. To ensure a known power-up state, the DAC8871 is designed with a power-on reset function. After power on, the state of the RSTSEL pin sets the value of the input register and DAC latch, which sets the output state of the V_{OUT} pin. Refer to the Power-On Reset and Hardware Reset section for more details.

Kelvin sense connections for the reference and analog ground are also included.

DIGITAL-TO-ANALOG SECTIONS

The DAC architecture consists of two matched DAC sections and is segmented. A simplified circuit diagram is shown in Figure 38. The four MSBs of the 16-bit data word are decoded to drive 15 switches, E1 to E15. Each of these switches connects one of 15 matched resistors to either AGND or V_{REF} . The remaining 12 bits of the data word drive switches S0 to S11 of a 12-bit voltage mode R-2R ladder network.

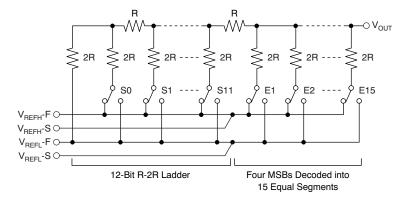


Figure 38. DAC Architecture

OUTPUT RANGE

The output of the DAC is:

$$V_{OUT} = \frac{(V_{REFH} - V_{REFL}) \times Code}{65536 + V_{REFL}}$$
(1)

Where Code is the decimal data word loaded to the DAC latch.

For example, if V_{REFH} is +10V, and V_{REFL} is -10V, the range of V_{OUT} is from -10V (code = 0000h) to +10V (code = FFFFh).

The range of V_{REFL} is from -18V to (V_{REFH} - 1.25V), and the range of V_{REFH} is 0V to +18V. The output from the DAC8871 can be unipolar (from 0V to +18V) or bipolar by setting the proper V_{REFL} and V_{REFH} values.



THEORY OF OPERATION (continued)

POWER-ON RESET AND HARDWARE RESET

The DAC8871 has a power-on reset function. When the RSTSEL pin is low (tied to DGND), and after power-on or a hardware reset signal is applied to the \overline{RST} pin, the DAC latch is cleared ('0') and the V_{OUT} pin is set to negative full-scale. When RSTSEL is high, the DAC latch and V_{OUT} are set to mid-scale.

SERIAL INTERFACE

The DAC8871 digital interface is a standard 3-wire connection compatible with SPI, QSPI™, Microwire™ and TI DSP™ interfaces, which can operate at speeds up to 50 Mbits/second. The data transfer is framed by the chip select (\overline{CS}) signal. The DAC works as a bus slave. The bus master generates the synchronize clock (SCLK) and initiates the transmission. When \overline{CS} is high, the DAC is not accessed, and SCLK and SDI are ignored. The bus master accesses the DAC by driving \overline{CS} low. Immediately following the high-to-low transition of \overline{CS} , the serial input data on the SDI pin are shifted out from the bus master synchronously on the falling edge of SCLK and latched on the rising edge of SCLK into the input shift register, MSB first. The low-to-high transition of \overline{CS} transfers the content of the input shift register to the input register.

All data registers are 16 bits. It takes 16 SCLK cycles to transfer one data word to the device. To complete a whole data word, \overline{CS} must be taken high immediately after the 16th SCLK is clocked in. If more than 16 SCLK cycles are applied while \overline{CS} is low, the last 16 bits are transferred into the input register on the rising edge of \overline{CS} . However, if \overline{CS} is not kept low during the entire 16 SCLK cycles, the data are corrupted. In this case, reload the DAC latch with a new 16-bit word.

The DAC8871 has an $\overline{\text{LDAC}}$ pin that allows the DAC latch to be updated asynchronously by bringing $\overline{\text{LDAC}}$ low after $\overline{\text{CS}}$ goes high. In this case, $\overline{\text{LDAC}}$ must be kept high while $\overline{\text{CS}}$ is low. If $\overline{\text{LDAC}}$ is permanently tied low, the DAC latch will be updated immediately after the input register is loaded (caused by the low-to-high transition of $\overline{\text{CS}}$).

EXTERNAL AMPLIFIER SELECTION

The output of the DAC8871 is unbuffered. The output impedance is approximately $6.2k\Omega$. If the applications require an external buffer amplifier, the selected amplifier must have a low-offset voltage (1LSB = $305\mu V$ for $\pm 10V$ output range), eliminating the need for output offset trims. Input bias current should also be low because the bias current multiplied by the DAC output impedance (approximately $6.25k\Omega$) adds to the zero-code error. Rail-to-rail input and output performance is required. For fast settling, the slew rate of the operational amplifier should not impede the settling time of the DAC. The output impedance of the DAC is constant and code-independent, but in order to minimize gain errors, the input impedance of the output amplifier should be as high as possible. The amplifier should also have a 3dB bandwidth of 1MHz or greater. The amplifier adds another time constant to the system, thus increasing the settling time of the output. A higher 3dB amplifier bandwidth results in a shorter effective settling time of the DAC and amplifier combination.

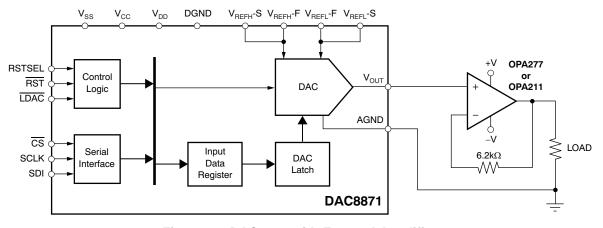


Figure 39. DAC8871 with External Amplifier



APPLICATION INFORMATION

REFERENCE INPUT

The DAC full-scale output voltage is determined by the reference voltage, as shown in the *Output Range* section.

Reference input V_{REFH} can be any voltage from 0V to +18V. Reference input V_{REFL} can be any voltage from -18V to 0V. The current into the V_{REFH} input and out of V_{REFL} depends on the DAC output voltages. Refer to Figure 27 and Figure 28 for details. The reference input appears as a varying load to the reference. If the reference can sink or source the required current, a reference buffer is not required. The DAC8871 features a reference drive (force) and sense connection that minimizes the internal errors caused by the changing reference current and the circuit impedances. Figure 40 shows a typical reference configuration.

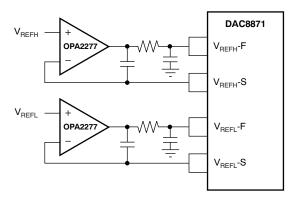


Figure 40. Buffered Reference Connection

POWER SUPPLY BYPASSING

For accurate, high-resolution performance, bypassing the supply pins with a $10\mu F$ tantalum capacitor in parallel with a $0.1\mu F$ ceramic capacitor is recommended.





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PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
DAC8871SBPW	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	Call TI	Level-2-260C-1 YEAR
DAC8871SBPWG4	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	Call TI	Level-2-260C-1 YEAR
DAC8871SBPWR	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	Call TI	Level-2-260C-1 YEAR
DAC8871SBPWRG4	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	Call TI	Level-2-260C-1 YEAR
DAC8871SPW	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	Call TI	Level-2-260C-1 YEAR
DAC8871SPWG4	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	Call TI	Level-2-260C-1 YEAR
DAC8871SPWR	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	Call TI	Level-2-260C-1 YEAR
DAC8871SPWRG4	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	Call TI	Level-2-260C-1 YEAR

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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PW (R-PDSO-G**)

14 PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

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